



钜地半导体
Tudi Semiconductor

Product Specification

TUDI-SN65HVD379DR

3.3 V FULL-DUPLEX RS-485/RS-422 DRIVERS AND BALANCED RECEIVERS

网址 www.sztdbdt.com Q

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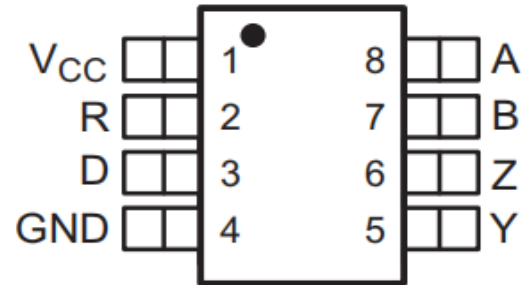
**semiconductor device
manufacturer**

- Design
- research and development
- production
- and sales



FEATURES

- Designed for INTERBUS Applications
- Designed for RS-422 and RS-485 Networks
- Balanced Receiver Thresholds
- 1/2 Unit-Load (up to 64 nodes on the bus)
- Bus-Pin ESD Protection 15KV HBM
- Bus-Fault Protection of -7V to 12V
- Thermal Shutdown Protection
- Power-Up/Down Glitch-free Bus Inputs and Outputs
- High Input Impedance With Low V_{CC}
- Monotonic Outputs During Power Cycling
- 5-V Tolerant Inputs



(TOP VIEW)

APPLICATIONS

- Digital Motor Control
- Utility Meters
- Chassis-to-Chassis Interconnections
- Electronic Security Stations
- Industrial, Process, and Building Automation
- Point-of-Sale (POS) Terminals and Networks
- DTE/DCE Interfaces

DESCRIPTION

The SN65HVD379 is a differential line driver and differential-input line receiver that operates with a 3.3-V power supply. Each driver and receiver has separate input and output pins for full-duplex bus communication designs. They are designed for balanced transmission lines and interoperability with ANSI TIA/EIA-485A, TIA/EIA-422-B, ITU-T v.11, and SO 8482:1993 standard-compliant devices. These differential bus drivers and receivers are monolithic, integrated circuits designed for full-duplex bi-directional data communication on multipoint bus-transmission lines at signaling rates (1) up to 25 Mbps. The SN65HVD379 is fully enabled with no external enabling pins.

The 1/2 unit load receiver has a higher receiver input resistance. This results in lower bus leakage current over the common-mode voltage range, and reduces the total amount of current that an RS-485 driver is forced to source or sink when transmitting.

The balanced differential receiver input threshold makes the SN65HVD379 more compatible with fieldbus requirements that define an external fail-safe structure.

(1) The signaling rate of a line is the number of voltage transitions that are made per second expressed in the units bps (bits per second).



ORDERING INFORMATION

SIGNALING RATE	UNIT LOADS	PART NUMBER ⁽¹⁾	SOIC MARKING
25 Mbps	1/2	SN65HVD379	

(1) These are The D package is available taped and reeled. Add an R suffix to the part number (ie. SN65HVD379DR).

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted^{(1) (2)}

		UNIT
V_{CC}	Supply voltage range	-0.3 V to 6 V
V_A, V_B, V_Y, V_Z	Voltage range at any bus terminal (A, B, Y, Z)	-9 V to 14 V
V_{TRANS}	Voltage input, transient pulse through 100 Ω . See Figure 8 (A, B, Y, Z) ⁽³⁾	-50 to 50 V
V_I	Input voltage range (D, DE, $\overline{RE}$)	-0.5 V to 7 V
P_{CONT}	Continuous total power dissipation	Internally limited ⁽⁴⁾
I_O	Output current (receiver output only, R)	11 mA

- (1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.
- (3) This tests survivability only and the output state of the receiver is not specified.
- (4) The Thermal shutdown protection circuit internally limits the continuous total power dissipation. Thermal shutdown typically occurs when the junction temperature reaches 165C.

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range unless otherwise noted

PARAMETER		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	3		3.6	V
V_I or V_{IC}	Voltage at any bus terminal (separately or common mode)	-7 ⁽¹⁾		12	
$1/t_{UI}$	Signaling rate			25	Mbps
R_L	Differential load resistance	54	60		Ω
V_{IH}	High-level input voltage	2		V_{CC}	V
V_{IL}	Low-level input voltage	0		0.8	
V_{ID}	Differential input voltage	-12		12	
I_{OH}	High-level output current	-60			mA
	Driver				
	Receiver	-8			
I_{OL}	Low-level output current			60	mA
	Driver				
	Receiver			8	
T_A	Ambient still-air temperature	-40		85	C

(1) The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.



RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V_{IT+}	Positive-going differential input threshold voltage	$I_O = -8 \text{ mA}$			0.2	V
V_{IT-}	Negative-going differential input threshold voltage	$I_O = 8 \text{ mA}$	-0.2			
V_{hys}	Hysteresis voltage ($V_{IT+} - V_{IT-}$)			50		mV
V_O	Output voltage	$V_{ID} = 200 \text{ mV}$, $I_O = -8 \text{ mA}$, See Figure 7	2.4			V
		$V_{ID} = -200 \text{ mV}$, $I_O = 8 \text{ mA}$, See Figure 7			0.4	
I_A or I_B	Bus input current	V_A or $V_B = 12 \text{ V}$		0.20	0.35	mA
		V_A or $V_B = 12 \text{ V}$, $V_{CC} = 0 \text{ V}$		0.24	0.40	
		V_A or $V_B = -7 \text{ V}$	-0.35	-0.18		
		V_A or $V_B = -7 \text{ V}$, $V_{CC} = 0 \text{ V}$	-0.25	-0.13		
C_{ID}	Differential input capacitance	$V_{ID} = 0.4 \sin(4E6\pi t) + 0.5 \text{ V}$, DE at 0 V		15		pF
I_{CC}	Supply current	D at 0 V or V_{CC} and No Load			2.1	mA

(1) All typical values are at 25°C and with a 3.3-V supply.

RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output	$V_{ID} = -1.5 \text{ V}$ to 1.5 V , $C_L = 15 \text{ pF}$, See Figure 7		26	45	ns
t_{PHL}	Propagation delay time, high-to-low-level output					
$t_{sk(p)}$	Pulse skew ($t_{PHL} - t_{PLH}$)				7	
$t_{sk(pp)}$	Part-to-part skew ⁽²⁾			5		
t_r	Output signal rise time				5	
t_f	Output signal fall time				6	

(1) All typical values are at 25°C and with a 3.3-V supply

(2) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

DEVICE POWER DISSIPATION – P_D

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
P_D	Device power dissipation	$R_L = 60$, $C_L = 50 \text{ pF}$, Input to D a 50% duty cycle square wave at indicated signaling rate $T_A = 85^\circ\text{C}$			197	mW

FUNCTION TABLES

DRIVER			RECEIVER	
INPUT	OUTPUTS		DIFFERENTIAL INPUTS	OUTPUTS
D	Y	Z	$V_{ID} = V_A - V_B$	R
H	H	L	$V_{ID} \leq -0.2 \text{ V}$	L
L	L	H	$-0.2 \text{ V} < V_{ID} < 0.2 \text{ V}$	?
Open	L	H	$0.2 \text{ V} \leq V_{ID}$	H



PARAMETER MEASUREMENT INFORMATION

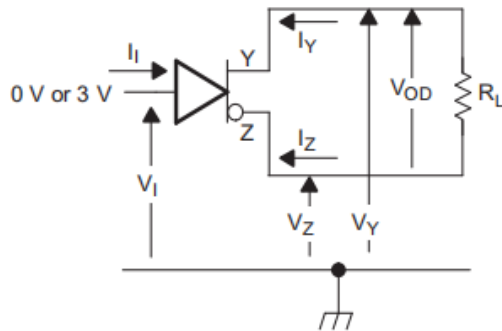


Figure 1. Driver V_{OD} Test Circuit and Voltage and Current Definitions

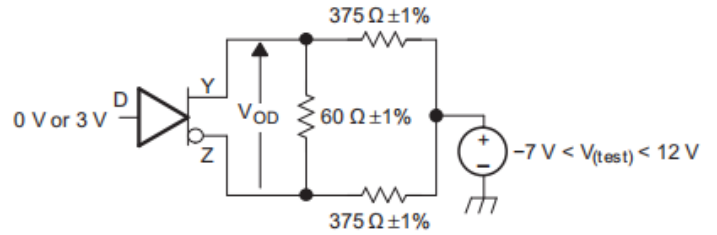


Figure 2. Driver V_{OD} With Common-Mode Loading Test Circuit

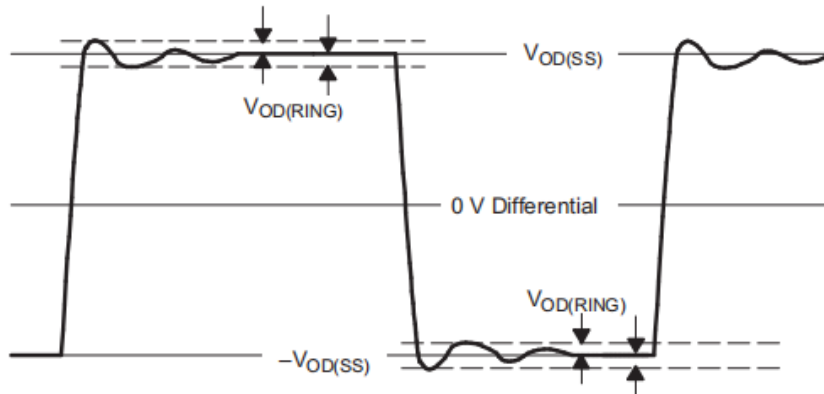
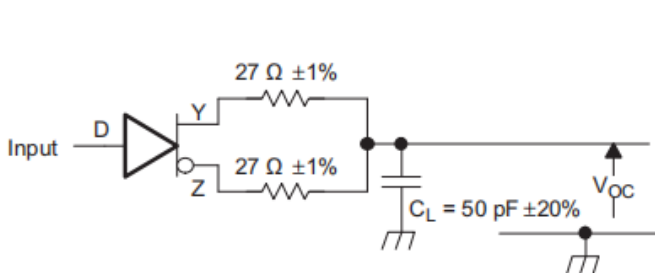


Figure 3. $V_{OD(RING)}$ Waveform and Definitions

$V_{OD(RING)}$ is measured at four points on the output waveform, corresponding to overshoot and undershoot from the $V_{OD(H)}$ and $V_{OD(L)}$ steady state values.



C_L Includes Fixture and Instrumentation Capacitance

Input: PRR = 500 kHz, 50% Duty Cycle, $t_r < 6$ ns, $t_f < 6$ ns, $Z_O = 50 \Omega$

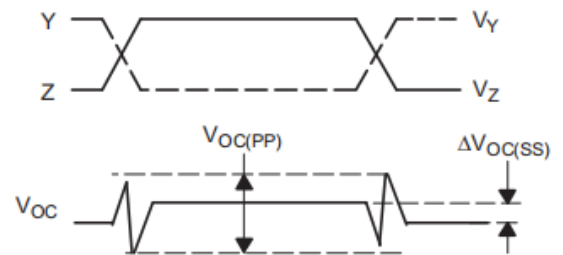


Figure 4. Test Circuit and Definitions for the Driver Common-Mode Output Voltage



PARAMETER MEASUREMENT INFORMATION (continued)

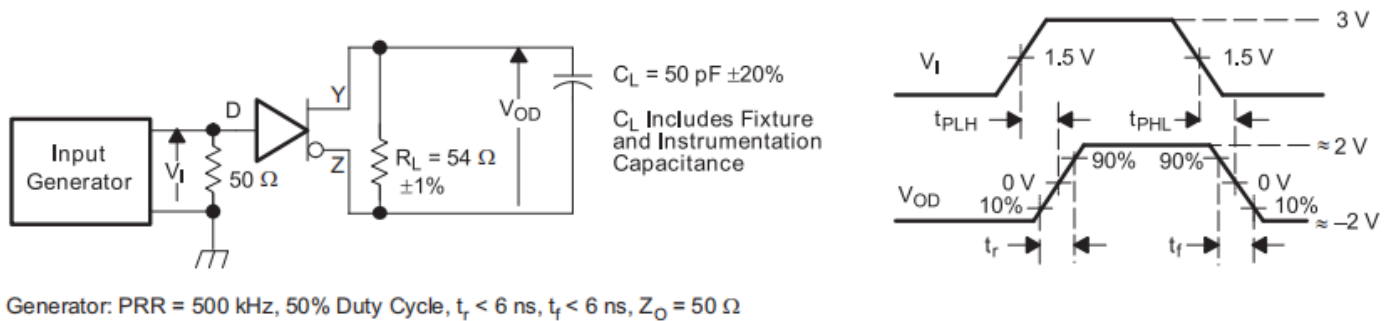


Figure 5. Driver Switching Test Circuit and Voltage Waveforms

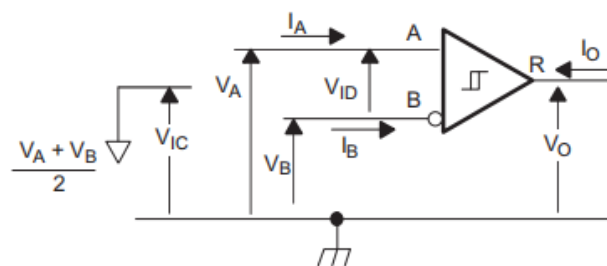


Figure 6. Receiver Voltage and Current Definitions

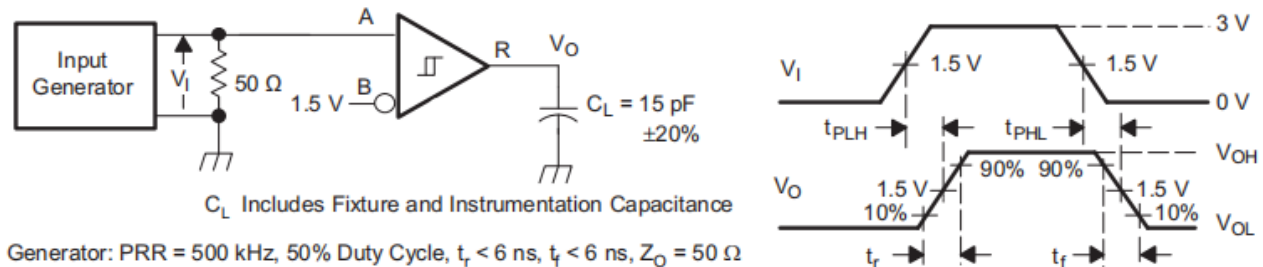


Figure 7. Receiver Switching Test Circuit and Voltage Waveforms

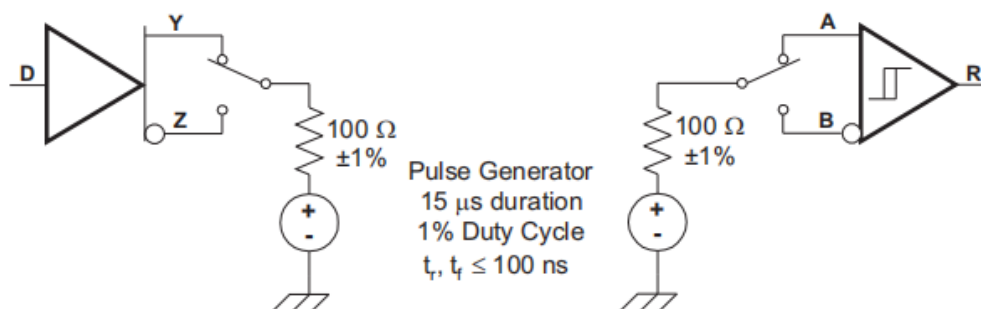
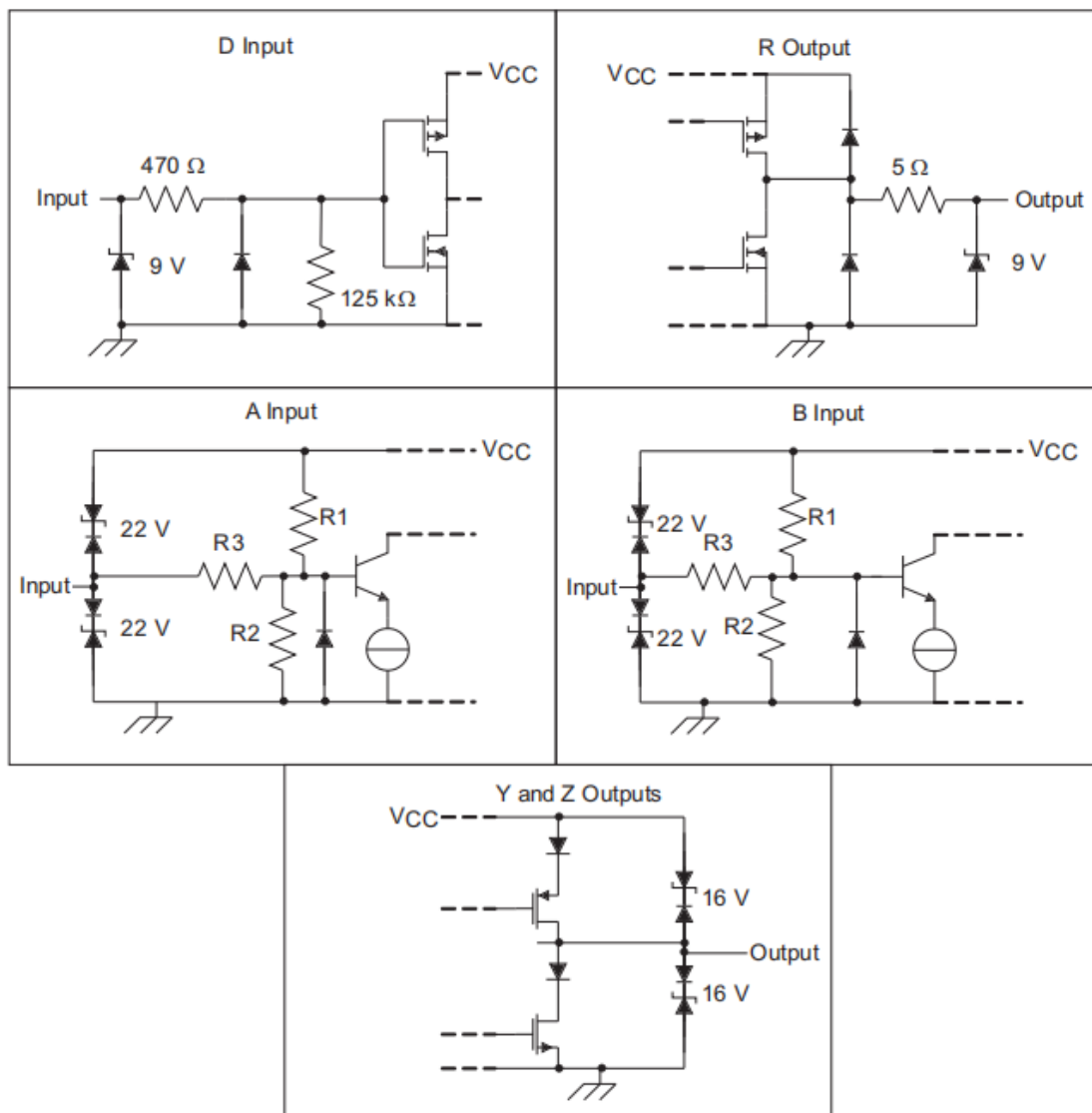


Figure 8. Test Circuit, Transient Over Voltage Test



EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



	R1/R2	R3
SN65HVD379	9 k Ω	45 k Ω

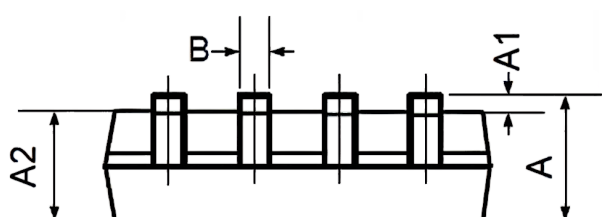
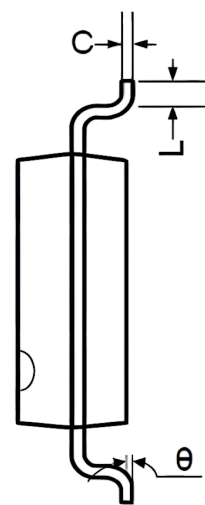
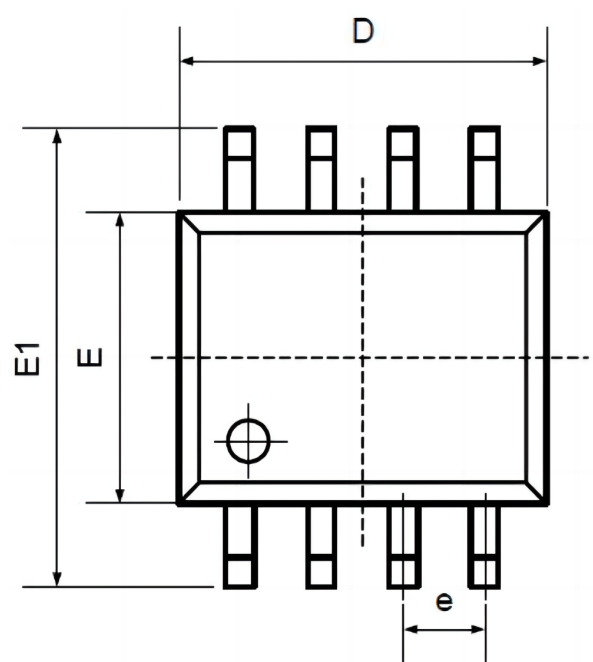


Order information

Order Number	Package	Package Quantity	Marking On The park
SN65HVD379DR-TUDI	SOP8	Tape,Reel,2500	SN65HVD379DR



Package SOP8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
B	0.330	0.510	0.013	0.020
C	0.190	0.250	0.007	0.010
D	4.780	5.000	0.188	0.197
E	3.800	4.000	0.150	0.157
E1	5.800	6.300	0.228	0.248
e	1.270TYP		0.050TYP	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



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